

- Nominal Frequency

19.440MHz

50 ±5(%) Typical, 50 ±10(%) Maximum

#### EV32C3 A 3 A 1 -19.440M

Duty Cycle

Series RoHS Compliant (Pb-free) 3.3V 6 Pad 5mm x 7mm Ceramic SMD LVCMOS/TTL VCXO (Tri-State Pad 5)

Operating Temperature Range 0°C to +70°C

Absolute Pull Range ±50ppm Minimum

Linearity

10% Typical, 20% Maximum

### **ELECTRICAL SPECIFICATIONS**

Moisture Resistance

**Moisture Sensitivity** 

Solderability

**Resistance to Solvents** 

**Temperature Cycling** 

**Resistance to Soldering Heat** 

Nominal Frequency	19.440MHz		
Frequency Tolerance/Stability	±50ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, Shock, and Vibration.)		
Aging at 25°C	±2ppm/first year Typical, ±10ppm/10 years Maximum		
Operating Temperature Range	0°C to +70°C		
Supply Voltage	3.3Vdc ±10%		
Input Current	15mA Maximum		
Output Voltage Logic High (Voh)	90% of Vdd Minimum (IOH = -4mA)		
Output Voltage Logic Low (Vol)	10% of Vdd Minimum (IOL = +4mA)		
Rise/Fall Time	5nSec Maximum (Measured at 20% to 80% of Waveform)		
Duty Cycle	50 $\pm$ 5(%) Typical, 50 $\pm$ 10(%) Maximum (Measured at 50% of Waveform)		
Load Drive Capability	15pF LVCMOS Load Maximum		
Output Logic Type	CMOS		
Absolute Pull Range	±50ppm Minimum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, Shock, Vibration, and Aging over the Control Voltage (Vc).)		
Control Voltage	0.3Vdc to 3.0Vdc (Test Condition for APR)		
Control Voltage Range	0.0Vdc to Vdd		
Linearity	10% Typical, 20% Maximum		
Transfer Function	Positive Tranfer Characteristic		
Modulation Bandwidth	10kHz Minimum (Measured at -3dB, Vc = 1.65Vdc)		
Input Impedance	50kOhms Minimum		
Input Leakage Current	10μA Maximum		
Phase Noise	-70dBc/Hz at offset of 10Hz, -100dBc/Hz at offset of 100Hz, -130dBc/Hz at offset of 1kHz, -147dBc/Hz at offset of 10kHz, -152dBc/Hz at offset of 100kHz, and -155dBc/Hz at offset of 1MHz (Typical Values at Fo = 27MHz)		
Tri-State Input Voltage (Vih and Vil)	+0.9Vdd Minimum to Enable Output; +0.1Vdd Maximum to Disable Output (High Impedance); No Connect to Enable Output.		
RMS Phase Jitter	1pSec Maximum (Fj = 12kHz to 20MHz)		
Start Up Time	10mSec Maximum		
Storage Temperature Range	-55°C to +125°C		
ENVIRONMENTAL & MECHANICAL SPECIFICATIONS			
ESD Susceptibility	MIL-STD-883, Method 3015, Class 1, HBM: 1500V		
Fine Leak Test	MIL-STD-883, Method 1014, Condition A		
Flammability	UL94-V0		
Gross Leak Test	MIL-STD-883, Method 1014, Condition C		
Mechanical Shock	MIL-STD-883, Method 2002, Condition B		
Meioture Desistence			

MIL-STD-883, Method 1004

MIL-STD-202, Method 215

MIL-STD-883, Method 2003

MIL-STD-202, Method 210, Condition K

MIL-STD-883, Method 1010, Condition B

J-STD-020, MSL 1

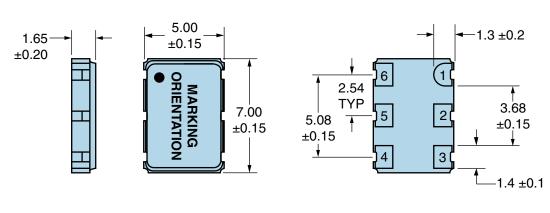


#### **ENVIRONMENTAL & MECHANICAL SPECIFICATIONS**

Vibration

MIL-STD-883, Method 2007, Condition A

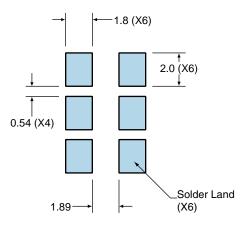
### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



PIN	CONNECTION
1	Control Voltage
2	No Connect
3	Case Ground
4	Output
5	Tri-State
6	Supply Voltage
LINE	MARKING
LINE 1	MARKING ECLIPTEK

#### Suggested Solder Pad Layout

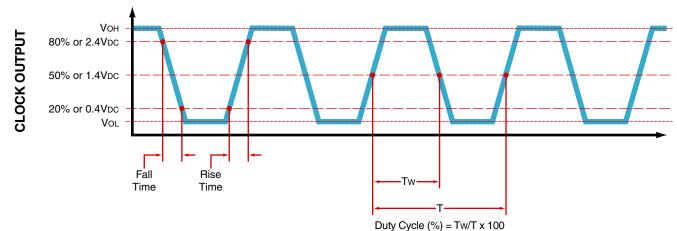
All Dimensions in Millimeters



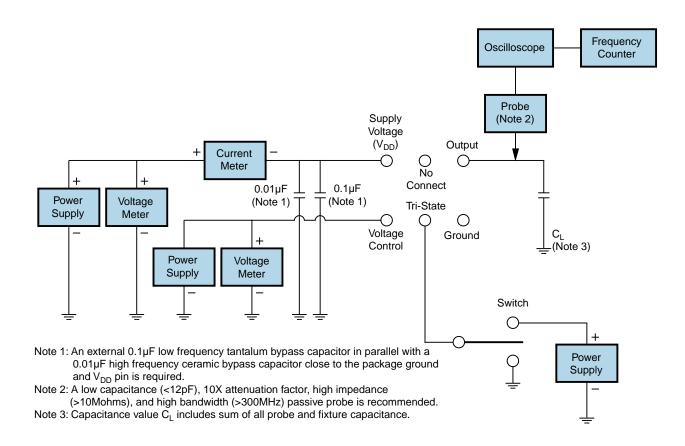
All Tolerances are ±0.1



#### **OUTPUT WAVEFORM**

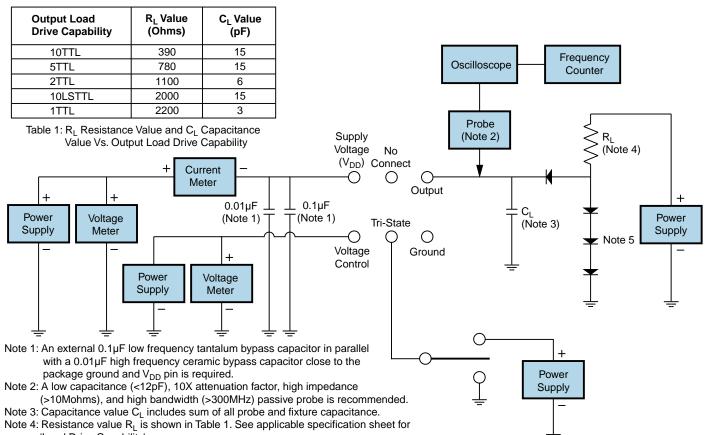


#### **Test Circuit for CMOS Output**





#### Test Circuit for TTL Output



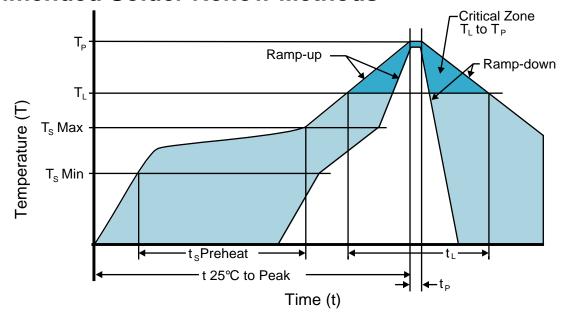
<sup>&#</sup>x27;Load Drive Capability'.

Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



# **Recommended Solder Reflow Methods**

EV32C3A3A1-19.440M



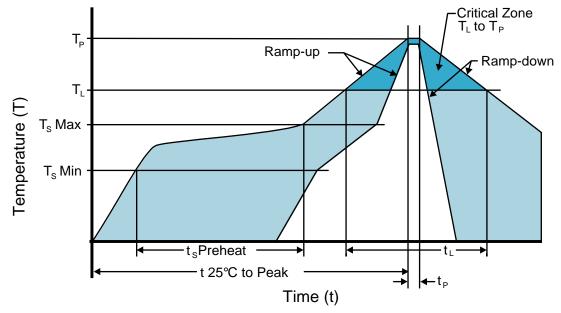
### **High Temperature Infrared/Convection**

$T_s$ MAX to $T_L$ (Ramp-up Rate)	3°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>s</sub> MIN)	150°C
- Temperature Typical (T <sub>s</sub> TYP)	175°C
- Temperature Maximum (T <sub>s</sub> MAX)	200°C
- Time (t <sub>s</sub> MIN)	60 - 180 Seconds
Ramp-up Rate (T⊾ to T <sub>P</sub> )	3°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	217°C
- Time (t∟)	60 - 150 Seconds
Peak Temperature (T <sub>P</sub> )	260°C Maximum for 10 Seconds Maximum
Target Peak Temperature (T <sub>P</sub> Target)	250°C +0/-5°C
Time within 5°C of actual peak ( $t_p$ )	20 - 40 seconds
Ramp-down Rate	6°C/second Maximum
Time 25°C to Peak Temperature (t)	8 minutes Maximum
Moisture Sensitivity Level	Level 1



## **Recommended Solder Reflow Methods**

EV32C3A3A1-19.440M



### Low Temperature Infrared/Convection 240°C

T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>s</sub> MIN)	N/A
- Temperature Typical (T <sub>s</sub> TYP)	150°C
- Temperature Maximum (T <sub>s</sub> MAX)	N/A
- Time (t <sub>s</sub> MIN)	60 - 120 Seconds
Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )	5°C/second Maximum
Time Maintained Above:	
- Temperature (T <sub>L</sub> )	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T <sub>P</sub> )	240°C Maximum
Target Peak Temperature (T <sub>P</sub> Target)	240°C Maximum 1 Time / 230°C Maximum 2 Times
Time within 5°C of actual peak (t <sub>p</sub> )	10 seconds Maximum 2 Times / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1

#### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.